

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. 250412US6	SERIAL NO. 10/800,685
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Hirofumi HAYAASHI, et al.	
		FILING DATE March 16, 2004	GROUP 2617

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						
AL						
AM						
AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION
					YES NO
	AO	JP 2003-044765	02/14/2003	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AP	JP 2002-269485	09-20-2002	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AQ	JP 2003-051870	02/21/2003	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AR	JP 2003-44910	02/14/2003	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AS	JP 2001-101300	04/13/2001	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AT	JP 2001-116556	04/27/2001	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AU	JP 2001-266034	09/28/2001	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AV	JP 2002-056331	02/20/2002	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AW	JP 2002-099858	04/05/2002	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AX	JP 2002-150191	05/24/2002	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AY	JP 2002-150256	05/24/2002	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x
	AZ	JP 2002-230203	08/16/2002	JAPAN (with English Abstract and unedited Computer-Generated English Translation)	x

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

Additional References sheet(s) attached

Date Considered

Examiner

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.